

<b>Notice of References Cited</b>	Application/Control No. 10/790,296	Applicant(s)/Patent Under Reexamination PHAN ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2004/0257571 a1	12-2004	Mieher et al.	356/401
	C	US-6,204,912 b1	03-2001	Tsuchiya et al.	355/53
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**NON-PATENT DOCUMENTS**

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